SUN 2 L 2001 PARTMENT OF COMMERCE PLAND TRADEMARK OFFICE PLAND TRADEMARK OFF			Auy. Docket No. 82991 PCW Customer No. 01333			rial No. 9/902,345
			Applicani: Paul W. Jones			
LIST OF ART CITED BY APPLICANT (Use several sheers if necessary)			Filing Date 10 July 2001			131 2132
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Examiner Initioj*	DOCUMENT NUMBER	DATE	NAME	CIASS	SUBCLASS	FILING DATE IF APPROPRIATE
9/	6,253,193	06-26-2001	Ginter et al.			
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Serial No. 09/902, 347 Not assigned Atty. Docket No. FORM PTO-1449 US DEPARTMENT OF COMMERCE 82991THC PATENT AND TRADEMARK OFFICE Customer No. 01333 If AFTER the later date of the first Office Action Paul W. Jones or 3 months from filing, use only with Rule 97(E) Certificate or Fee LIST OF ART CITED BY APPLICANT Filing Date 2132 Group Filed herewith Not assigned (Use several sheets (f necessary) U.S. PATENT DOCUMENTS NAME CLASS SUBCLASS FILING DATE DOCUMENT NUMBER DATE Examiner IF APPROPRIATE Mar. 28, 2000 6.044.156 Honsinger et al. July 27, 1999 5,930,369 Cox et al. May 4, 1999 5,901,178 Lee et al. Sept. 15, 1998 Girod et al. 5,809,139 June 3, 1997 Rhoads 5,636,292 FOREIGN PATENT DOCUMENTS DATE COUNTRY CLASS SUBCLASS DOCUMENT NUMBER TRANSLATION Initial* OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) Anderson et al., Tamper Resistance - a Cautionary Note, The Second USENIX Workshop on Electronic Commerce Proceedings, November 1996, pp. 1-11 Textbook: Menezes et al., Handbook of Applied Cryptography, 19997, CRC Press, Inc. Hartung et al., Multimedia Watermarking Techniques, Proceedings of the IEEE, Vol. 87, No. 7, July 1999, pp. 1079-1107 Wolfgang et al., Perceptual Watermarks for Digital Images and Video, Proceedings of the IEEE, Vol. 87, No. 7, July 1999, pp. 1108-1126 DATE CONSIDERED EXAMINER *EXAMINES: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.